PXIe-4480 Specifications



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PXIe-4480 Specifications

Definitions

Warranted specifications describe the performance of a model under stated operating conditions and are covered by the model warranty.

Characteristics describe values that are relevant to the use of the model under stated operating conditions but are not covered by the model warranty.

- *Typical* specifications describe the performance met by a majority of models.
- **Nominal** specifications describe an attribute that is based on design, conformance testing, or supplemental testing.

Specifications are *Typical* unless otherwise noted.

Conditions

Specifications are valid for the range 0 °C to 55 °C unless otherwise noted.

PXIe-4480 Pinout

Figure 1. PXIe-4480 Pinout

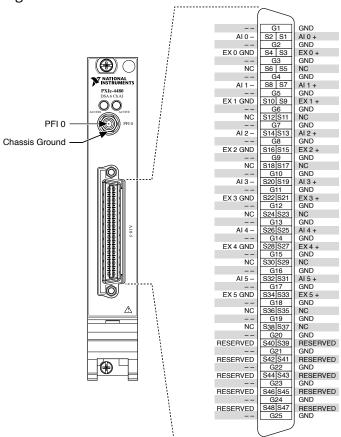


Table 1. Signal Descriptions

Signal	Reference	Description
AI <05>+, AI <05>-		Analog Input Channel—AI+ and AI- are the positive and negative inputs of the differential analog channel.
EX <05>+	EX <05> GND	Voltage Excitation—EX+ is the positive terminal of the voltage excitation channel.
EX <05> GND	_	Voltage Excitation Ground—Ground terminal of the voltage excitation channels.
GND		Ground—Ground terminal.
NC	_	Not Connected—These pins have no functionality.
RESERVED	_	Reserved for accessories or other use.

Signal	Reference	Description
PFI 0	GND	Programmable Function Interface—A digital trigger input.

Table 2. ACCESS LED State/Device Status

LED Color	Status
Green	The module is ready to be accessed by software.
Amber	The module is being accessed. The ACCESS LED flashes amber for 75 ms when the module is accessed.
Off	The module is not yet functional, or has detected a problem with a power rail.

Table 3. ACTIVE LED State/Device Status

LED Color	Status
Red	An error has been detected by hardware. Clear the error by resetting the module.
Blinking Amber/Green	The module is changing reference clock timebase.
Green	An acquisition has been triggered, and the module is currently acquiring data.
Amber	The module is waiting for a trigger event to start an acquisition.
Off	The moodule is not acquiring or preparing to acquire data.

Input Characteristics

Number of simultaneously sampled input channels	6
Measurement types	Voltage or Charge, each channel independently software-selectable
Input configuration	

Voltage	Differential or pseudodifferential (50 Ω between negative input and chassis ground), each channel independently software-selectable				
Charge	Charge Single-ended (negative input grounded)				
Input co	upli	ng			
Voltage					
Charge	e AC				
A/D conv	A/D converter (ADC) resolution 24 bits				
ADC type Delta-Sigma			Delta-Sigma		
Sample	rate	s (f _s)			
Range 100		100	Sample/s to 1.25 MSample/s		
Resolution ¹ ≤1.4		≤1.4	458 mSample/s		
ADC mod	ADC modulator sample rate			20 MSample/s	
FIFO buffer size			1,023 samples per task + 8,221 samp	les per channel in task	

1. Dependent on the sample rate. Refer to the *PXIe-4480/4481 User Manual* for more information.

Data transfers	Direct Memory Access (DMA), Programmed I/O
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Common-Mode Range (Voltage)

	Configuration		
Input	Differential (V peak)*	Pseudodifferential (V peak)*	
Positive input (+)	±10	±10	
Negative input (-)	±10	±10	
* Voltages with respect to chassis ground.			

Signal Range (Voltage)

*	Full-Scale Inp	out, Minimum
Range (V) *	V peak	V RMS [†]
10	±10.0 [‡]	7.07 [‡]
5	±5.0	3.53
1	±1.0	0.707
0.5	±0.5	0.353

^{*} Each input channel range is independently software-selectable.

[†] Sine input.

[‡] Typical.

Signal Range (Charge)

*	Full-Scale Inp	out, Minimum
Range (pC)	Q peak (pC)	Q RMS (pC) [†]
20,000	±20,000 [‡]	14,140 [‡]
10,000	±10,000	7,070
2,000	±2,000	1,414
1,000	±1,000	707

^{*} Each input channel range is independently software-selectable.

Overvoltage Protection (Voltage)

	Configuration		
Input	Differential (V peak)*	Pseudodifferential (V peak)*	
Positive input (+)	±30	±30	
Negative input (-)	±30	±10	

^{*} Voltages with respect to chassis ground.

Overvoltage Protection (Charge)

Input	Voltage (V peak)*
Positive input (+)	±15
Negative input (-)	None

[†] Sine input.

[‡] Typical.

Input	Voltage (V peak)*
* Voltages with respect to chassis ground.	

Overvoltage Protection (Unpowered)

Input	Voltage (V peak)*
Positive input (+)	±15
Negative input (-)	±15

^{*} Voltages with respect to chassis ground.

Transfer Characteristics Offset (Residual DC)

Range (V)	DC-Coupled Offset (±mV) [*] , Maximum (Typical)	AC-Coupled Offset (±mV) [†] , Typical, 25 °C	AC-Coupled Offset (±mV) [†] , Maximum, 55 °C
10	5.0 (2.0)	1.1	7.0
5	2.2 (1.0)	0.6	5.0
1	0.8 (0.5)	0.3	4.2
0.5	0.65 (0.4)	0.3	4.2

^{*} Source impedance ≤ 50 Ω.

[†] Applied DC bias \leq 15 V.

Gain Amplitude Accuracy

Voltage		
1 kHz input tone	±0.05 dB maximum, ±0.02 dB typical	
Charge		
1 kHz input tone	±0.1 dB maximum, ±0.06 dB typical	

Amplifier Characteristics

Input Impedance (Voltage)

Innut Impodance	Config	Configuration	
Input Impedance	Differential	Pseudodifferential	
Between positive input and chassis ground	1.62 MΩ 200 pF	1.62 MΩ 200 pF	
Between negative input and chassis ground	1.62 MΩ 200 pF	50 Ω	

Common-Mode Rejection Ratio (CMRR)

Range (V)	DC-Coupled CMRR (dBc)*,†	AC-Coupled CMRR (dBc) ^{*,‡}
10	60	60
5	70	70
1	85	80
0.5	90	80

 $f_{in} \le 1 \text{ kHz.}$

[†] Differential configuration.

OC-Coupled CMRR (dBc) ^{*,†}	AC-Coupled CMRR (dBc) ^{*,‡}
	OC-Coupled CMRR (dBc) ^{^, T}

Dynamic Characteristics

Bandwidth and Alias Rejection

Alias-free bandwidth (BW) (passband)	DC to 0.403 f _s
Alias rejection	120 dBc minimum, 0.597 $f_{\rm S}$ < $f_{\rm in}$ < 19.25375 MHz

Filter Delay

Digital filter delay	Adjustable ²
Analog filter delay	
10 V range	31 ns
5 V range	47 ns
1 V range	150 ns
0.5 V range	215 ns

2. Digital filter delay is compensated to 0 ns by default and adjustable in software.

AC Coupling (Voltage)

-3 dB cutoff frequency	0.49 Hz
-0.1 dB cutoff frequency	3.2 Hz

Figure 2. AC-Coupled Voltage Measurement Magnitude Response vs. Frequency

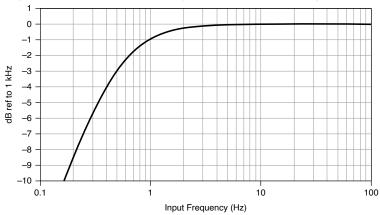
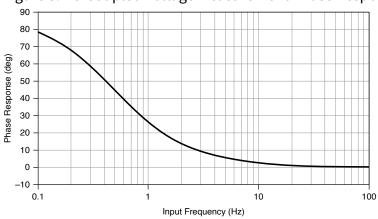


Figure 3. AC-Coupled Voltage Measurement Phase Response vs. Frequency



AC Coupling (Charge)

-3 dB cutoff frequency	2.2 Hz
-0.1 dB cutoff frequency	13.5 Hz

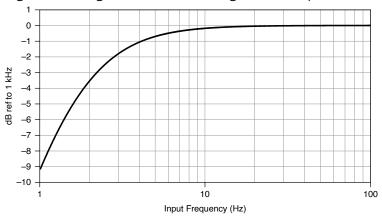


Figure 4. Charge Measurement Magnitude Response vs. Frequency

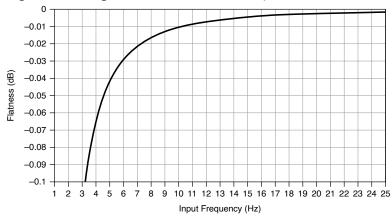
Gain Flatness (Voltage)

		$f_s = 1.25 \text{ MSamples/s}$						
Range (V)		DC-Coupled Flatness (dB)*, Maximum (Typical)						
3 ()	f _{in} = 20 Hz to 20 kHz		f _{in} > 50 kHz to 100 kHz	f _{in} > 100 kHz to 200 kHz	f _{in} > 200 kHz to 500 kHz			
10	±0.007 (±0.001)	±0.013 (±0.003)	±0.03 (±0.003)	±0.11 (±0.005)	(±0.025)			
5	±0.007 (±0.001)	±0.013 (±0.003)	±0.03 (±0.0035)	±0.11 (±0.0055)	(±0.04)			
1	±0.007 (±0.001)	±0.016 (±0.004)	±0.057 (±0.022)	±0.22 (±0.1)	(±0.6)			
0.5	±0.008 (±0.002)	±0.025 (±0.012)	±0.094 (±0.055)	±0.36 (±0.23)	(±1.25)			
* Relative to 1 kHz.								

		MSamples/s							
_ (1.0)		AC-Coupled Flatness (dB)*, Maximum (Typical)							
Range (V)	f _{in} ≤ 25 Hz	f _{in} > 25 Hz to 20 kHz	f _{in} > 20 kHz to 50 kHz	f _{in} > 50 kHz to 100 kHz	f _{in} > 100 kHz to 200 kHz	f _{in} > 200 kHz to 500 kHz			
10	Refer to the following figure.	±0.007 (±0.001)	±0.013 (±0.003)	±0.03 (±0.003)	±0.11 (±0.005)	(±0.025)			
5	Refer to the following	±0.007 (±0.001)	±0.013 (±0.003)	±0.03 (±0.0035)	±0.11 (±0.0055)	(±0.04)			

	$f_s = 1.25 \text{ MSamples/s}$								
Range (V)		AC-Coupled Flatness (dB)*, Maximum (Typical)							
	f _{in} ≤ 25 Hz	f _{in} > 25 Hz to 20 kHz	f _{in} > 20 kHz to 50 kHz	f _{in} > 50 kHz to 100 kHz	f _{in} > 100 kHz to 200 kHz	f _{in} > 200 kHz to 500 kHz			
	figure.								
1	Refer to the following figure.	±0.007 (±0.001)	±0.016 (±0.004)	±0.057 (±0.022)	±0.22 (±0.1)	(±0.6)			
0.5	Refer to the following figure.	±0.008 (±0.002)	±0.025 (±0.012)	±0.094 (±0.055)	±0.36 (±0.23)	(±1.25)			
* Relative to 2	* Relative to 1 kHz.								

Figure 5. Voltage Measurement AC-Coupled Gain Flatness



Gain Flatness (Charge)

	$f_S = 1.25 \text{ MSample/s}$							
D ((6)		Flatness (dBc) ^{*,†}						
Range (pC)	C)	f _{in} > 60 Hz to 20 kHz	f _{in} > 20 kHz to 50 kHz	f _{in} > 50 kHz to 100 kHz	f _{in} > 100 kHz to 200 kHz	f _{in} > 200 kHz to 500 kHz		
20,000	Refer to the following	±0.001	±0.003	±0.003	±0.005	±0.025		

_		Flatness (dBc) ^{*,†}							
Range (pC)	f _{in} ≤ 60 Hz	f _{in} > 60 Hz to 20 kHz	f _{in} > 20 kHz to 50 kHz	f _{in} > 50 kHz to 100 kHz	f _{in} > 100 kHz to 200 kHz	f _{in} > 200 kHz to 500 kHz			
	figure.								
10,000	Refer to the following figure.	±0.001	±0.003	±0.0035	±0.0055	±0.04			
2,000	Refer to the following figure.	±0.001	±0.004	±0.022	±0.1	±0.6			
1,000	Refer to the following figure.	±0.002	±0.012	±0.055	±0.23	±1.25			

^{*} Relative to 1 kHz.

Charge Measurement Filter

OFF	None
ON	2nd order, 30 kHZ low-pass filter

 $^{^{\}dagger}$ Charge filter OFF.

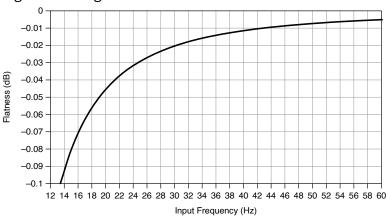


Figure 6. Charge Measurement Gain Flatness

Interchannel Gain Mismatch (Voltage)

Range (V)	AC/DC-Coupled Mismatch (dB) [*] , Maximum, (Typical)			AC-Coupled Mismatch (dB) [*] , Maximum (Typical)	
Kange (V)	f _{in} = 20 Hz to 20 kHz			f _{in} = 5 Hz	f _{in} = 10 Hz
10	0.011 (0.005)	0.011 (0.005)	0.011 (0.005)		
5	0.013 (0.006)	0.013 (0.006)	0.013 (0.006)		0.010 (0.000)
1	0.015 (0.007)	0.015 (0.007)	0.019 (0.009)	0.019 (0.009)	0.015 (0.007)
0.5	0.015 (0.007)	0.017 (0.008)	0.034 (0.017)		
* Identical channel configurations.					

Interchannel Phase Mismatch (Voltage)

Range (V)	AC/DC-Coupled Mismatch*, Maximum, (Typical)			AC-Coupled Mismatch Maximum (Typical)	
Ralige (V)	f _{in} = 20 Hz to 20 kHz	f _{in} > 20 kHz to 50 kHz	f _{in} > 50 kHz to 100 kHz	f _{in} = 5 Hz	f _{in} = 10 Hz
10	0.02° (0.01°)	0.05° (0.025°)	0.1° (0.05°)		0.179 (0.009)
5	0.04° (0.02°)	0.10° (0.05°)	0.2° (0.1°)	0.34° (0.17°)	
1	0.24° (0.12°)	0.60° (0.30°)	1.2° (0.6°)		0.17° (0.09°)
0.5	0.38° (0.19°)	0.96° (0.48°)	1.9° (0.95°)		

Pango (V)	AC/DC-Coupled	AC-Coupled Mismatch [*] , Maximum (Typical)			
Range (V)	f _{in} = 20 Hz to 20 kHz	f _{in} > 20 kHz to 50 kHz	f _{in} > 50 kHz to 100 kHz	f _{in} = 5 Hz	f _{in} = 10 Hz
*					

Identical channel configurations.



Note Listed gain and phase mismatch specifications are valid for measurements made on channels on the same module. For measurements made on channels on different modules, the listed gain and phase mismatch specifications still apply, but are subject to the following conditions:

- For gain matching, all modules must be properly warmed up. Refer to the Environmental section for the specified warm-up time.
- For phase matching, all modules must be synchronized to a common timebase. To the listed specifications, add the following error: $360^{\circ} \times f_{in} \times clock$ skew. Refer to the Timing and Synchronization section for the maximum intermodule clock skew.

Idle Channel Noise (Voltage)

Idle Channel Noise (μV RMS) [*]				
$f_{\rm S}$ = 51.2 kSample/s	$f_s = 204.8 \text{ kSample/s}$	$f_s = 1.25 \text{ MSample/s}$		
16	32	87		
6.5	13	35		
1.8	3.6	9.1		
1.5	3.0	7.1		
	f _s = 51.2 kSample/s 16 6.5 1.8	$f_s = 51.2 \text{ kSample/s}$ $f_s = 204.8 \text{ kSample/s}$ 16 32 6.5 13 1.8 3.6		

Dynamic Range (Voltage)

Range (V)	Dynamic Range (dBFS)*,†			
	f _s = 51.2 kSample/s	f _s = 204.8 kSample/s	$f_s = 1.25 \text{ MSample/s}$	
10	113	107	98	
5	115	109	100	
1	112	106	98	
0.5	107	101	94	

^{*} 1 kHz tone, -60 dBFS input amplitude.

Idle Channel Noise (Charge)

Range (pC)	Idle Channel Noise (fC RMS)*				
Ralige (pc)	$f_s = 51.2 \text{ kSample/s}$	$f_s = 204.8 \text{ kSample/s}$	$f_s = 1.25 \text{ MSample/s}$		
20,000	32	64	174		
10,000	16	30	75		
2,000	13	18	25		
1,000	13	18	25		

^{*} Charge filter OFF.

Representative Measurement FFTs (1 kHz)

Test conditions for all FFTs: Unaveraged computation of 1.6 million samples, differential input configuration.

[†] Source impedance ≤ 50 Ω.

Figure 7. -3 dBFS, 1 kHz Tone Acquired at 1.25 MSample/s, 10 V Range (Full Bandwidth)

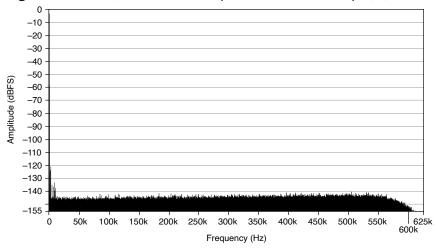


Figure 8. -3 dBFS, 1 kHz Tone Acquired at 1.25 MSample/s, 10 V Range (20 kHz Bandwidth)

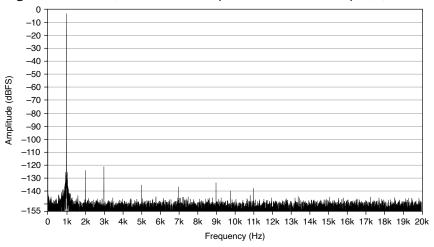


Figure 9. -3 dBFS, 1 kHz Tone Acquired at 1.25 MSample/s, 5 V Range (Full Bandwidth)

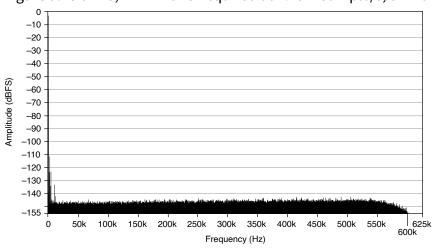


Figure 10. -3 dBFS, 1 kHz Tone Acquired at 1.25 MSample/s, 5 V Range (20 kHz Bandwidth)

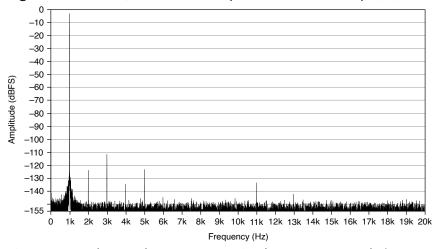


Figure 11. -3 dBFS, 1 kHz Tone Acquired at 1.25 MSample/s, 1 V Range (Full Bandwidth)

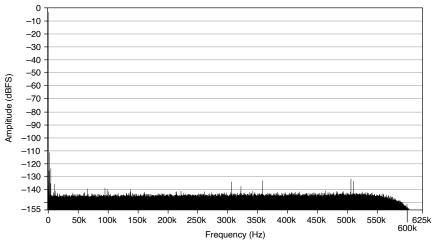
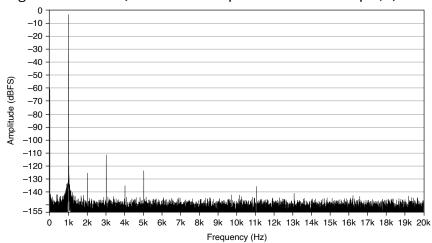


Figure 12. -3 dBFS, 1 kHz Tone Acquired at 1.25 MSample/s, 1 V Range (20 kHz Bandwidth)



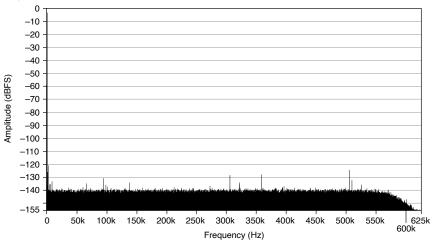
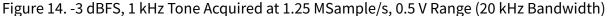
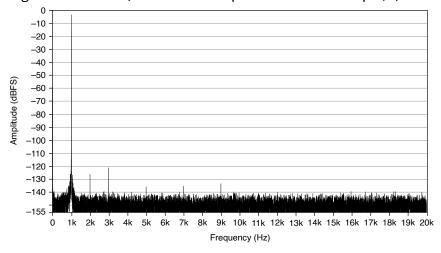


Figure 13. -3 dBFS, 1 kHz Tone Acquired at 1.25 MSample/s, 0.5 V Range (Full Bandwidth)





Representative Measurement FFTs (10 kHz)

Test conditions for all FFTs: Unaveraged computation of 1.6 million samples, differential input configuration.

Figure 15. -3 dBFS, 10 kHz Tone Acquired at 1.25 MSample/s, 10 V Range (Full Bandwidth)

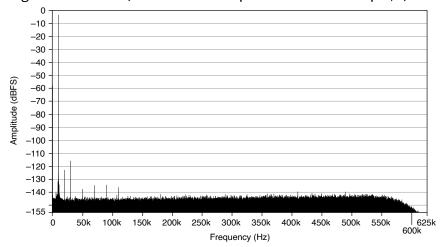


Figure 16. -3 dBFS, 10 kHz Tone Acquired at 1.25 MSample/s, 10 V Range (150 kHz Bandwidth)

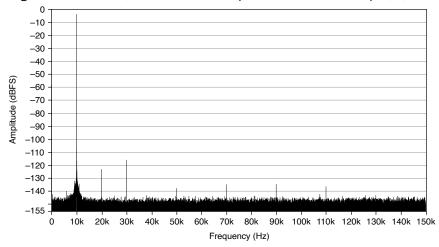


Figure 17. -3 dBFS, 10 kHz Tone Acquired at 1.25 MSample/s, 5 V Range (Full Bandwidth)

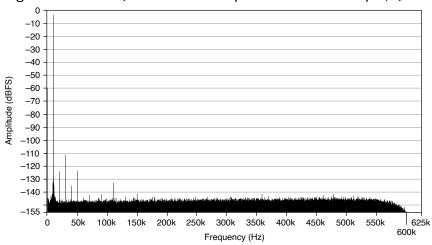


Figure 18. -3 dBFS, 10 kHz Tone Acquired at 1.25 MSample/s, 5 V Range (150 kHz Bandwidth)

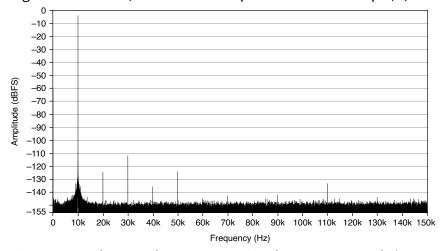


Figure 19. -3 dBFS, 10 kHz Tone Acquired at 1.25 MSample/s, 1 V Range (Full Bandwidth)

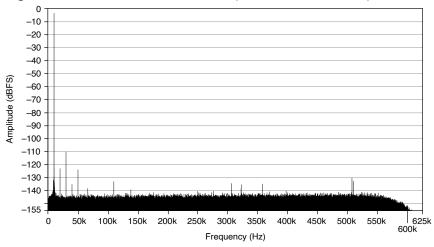
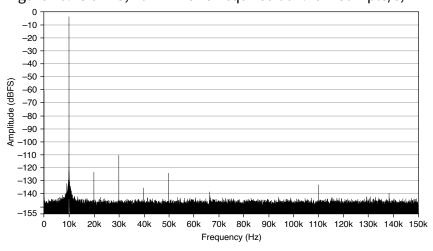


Figure 20. -3 dBFS, 10 kHz Tone Acquired at 1.25 MSample/s, 1 V Range (150 kHz Bandwidth)



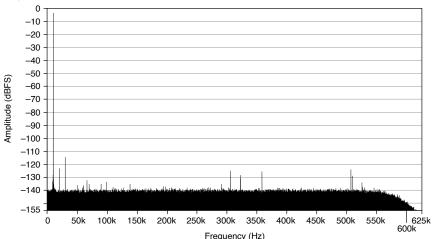
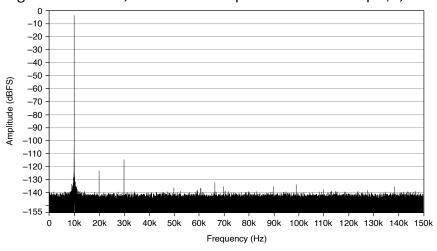


Figure 21. -3 dBFS, 10 kHz Tone Acquired at 1.25 MSample/s, 0.5 V Range (Full Bandwidth)

Figure 22. -3 dBFS, 10 kHz Tone Acquired at 1.25 MSample/s, 0.5 V Range (150 kHz Bandwidth)



Spurious Free Dynamic Range (Voltage)

Pango (V)	SFDR (dBC)*,†,‡			
Range (V)	$f_s = 51.2 \text{ kSample/s}$	$f_s = 204.8 \text{ kSample/s}$	$f_s = 1.25$ MSample/s	
10	100	100	100	
5	100	100	100	
1	100	100	94	
0.5	100	100	88	

^{*} 1 kHz input tone, input amplitude is -3 dBFS.

Range (V)	SFDR (dBC)*,†,‡		
Range (V)	$f_s = 51.2 \text{ kSample/s}$	f _s = 204.8 kSample/s	$f_s = 1.25 \text{ MSample/s}$

[†] Differential configuration.

Total Harmonic Distortion (THD), Balanced Source

			THD (dBC) ^{*,†}		
Range (V)	f _s = 51.2 kSample/s		$f_s = 204.8 \text{ kSample/s}$		e/s
	f _{in} = 1 kHz	f _{in} = 20 Hz to 20 kHz	f _{in} = 1 kHz	f _{in} = 20 Hz to 20 kHz	f _{in} > 20 kHz to 80 kHz
10, 5, 1, 0.5	-100	-100	-100	-98	-96

^{*} Input amplitude is -3 dBFS.

THD (dBC) ^{*,†}					
Range (V)		f _s = 1.25 MSample/s			
3 . ,	f _{in} = 1 kHz	f _{in} = 10 kHz	f _{in} = 20 Hz to 20 kHz	f _{in} > 20 kHz to 50 kHz	f _{in} > 50 kHz to 100 kHz
10, 5, 1, 0.5	-100	-99	-98	-95	-90

^{*} Input amplitude is -3 dBFS.

[‡] Evaluation BW = 10 Hz to 0.4 f_s

[†] Differential configuration.

[†] Differential configuration.

Total Harmonic Distortion (THD), Unbalanced Source

	THD (dBC)*,†				
Range (V)	$f_s = 51.2 \text{ kSample/s}$		f _s = 204.8 kSample/s		e/s
•	f _{in} = 1 kHz	f _{in} = 20 Hz to 20 kHz	f _{in} = 1 kHz	f _{in} = 20 Hz to 20 kHz	f _{in} > 20 kHz to 80 kHz
10	-100	-97	-100	-90	-85
5, 1, 0.5	-100	-100	-100	-97	-96

^{*} Input amplitude is -3 dBFS.

 $^{^\}dagger$ Pseudodifferential configuration.

	THD (dBC) ^{*,†}				
Range (V)	$f_{\rm S}$ = 1.25 MSample/s				
•	f _{in} = 1 kHz	f _{in} = 10 kHz	f _{in} = 20 Hz to 20 kHz	f _{in} > 20 kHz to 50 kHz	f _{in} > 50 kHz to 100 kHz
10	-100	-95	-90	-81	-74
5, 1, 0.5	-100	-98	-97	-92	-81

^{*} Input amplitude is -3 dBFS.

Crosstalk, Input Channel Separation

Range (V)	Crosstalk (dBC)*,†		
Ralige (V)	$f_{\text{in}} = 1 \text{ kHz}$ $f_{\text{in}} = 1$		
10, 5, 1, 0.5	-140	-100	

[†] Pseudodifferential configuration.

Range (V)	Crosstalk (dBC)*,†		
Range (V)	f_{in} = 1 kHz	f _{in} = 100 kHz	
* Input amplitude is -1 dBFS. † Source impedance is ≤ 50 Ω			

Voltage Reference

DC level	4,096 V
Temperature coefficient	5 ppm/°C maximum
Time stability	20 ppm/1,000 hr

IEPE Excitation

Current set	Current settings		
OFF	0 mA		
4 mA	4 mA minimum, 4.15 mA typical, 4.3 mA maximum		
10 mA	9.7 mA minimum, 10 mA typical, 10.3 mA maximum		
20 mA	19.4 mA minimum, 20 mA typical, 20.6 mA maximum		

Each channel independently software-selectable.

|--|



Note Use the following equation to make sure that your configuration meets the IEPE voltage compliance range: CommonMode + Bias \pm FullScale + (Excitation x 50 Ω) must be 0 V to 22 V, where

CommonMode is the common-mode voltage seen by the input channel, Bias is the DC bias voltage of the sensor, FullScale is the AC full-scale voltage of the sensor, and Excitation is the selected excitation setting.

Sensor open detection ^{3[3]} (software-readable)		
4 mA	23 V	
10 mA	22.5 V	
20 mA	22 V	
Sensor short detection ^[3] (software-readable)		
4 mA	1.3 V	
10 mA	1 V	
20 mA	0.5 V	

3. Voltage between positive input (+) and negative input (-).

Channel input impedance with IEPE enabled	1.62 MΩ 250 pF, pseudodifferential
Chamber impedance with Er 2 chabited	1.02 MII 200 pr, poeddodinerendal

Transducer Electronic Data Sheet

Supports Transducer Electronic Data Sheet (TEDS) according to the IEEE 1451 Standard

Class I, all module inputs



Note For more information about TEDS, visit <u>ni.com/r/rdteds</u>.

Maximum load capacitance	10,000 pF
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Voltage Excitation

Voltage settings	
OFF	0 V
10 V (fixed)	10 V
25 V (fixed)	25 V
Adjustment range	9.5 V to 11.98 V
Adjustment resolution	10 mV

Each channel independently software-selectable.

Load regulation ⁴	0.01%/mA
Output current (per channel)	25 mA minimum
Current limit detection (software-readable)	27.5 mA

Frequency Timebase Characteristics

Accuracy	
Using internal VCXO timebase	±50 ppm maximum
Using external timebase	Equal to accuracy of external timebase

Timing and Synchronization

Number of timing engines ⁵	3	
Reference clock source	Onboard clock, backplane PXIe_Cl	_K100
Intermodule ADC clock skew ⁶		
T _{tb} ±5 °C		11 ns max ⁷

- 4. Excludes the effect of external cable resistance.
- 5. Two timing engines are dedicated to analog input and two timing engines are dedicated to analog output. Channels can be arbitrarily grouped and assigned to timing engines of the same channel type. Timing engines can be independently synchronized, started, and stopped. All timing engines must use the same reference clock source. Refer to the module user manual for more details on the assignment of timing engines.

Over full operating temperature range	20 ns max
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Triggers

Analog trigger			
Purpose	Reference trigge	Reference trigger only	
Source	Any channel	Any channel	
Level	Full scale, programmable		
Mode	Rising-edge or falling-edge with hysteresis, entering or leaving window		
Resolution	24 bits		
Digital trigger			
Purpose Start or reference trigger		Start or reference trigger	
Source PFI0, PXI_Trig<07>, PXI_Star, PXIe_DStar <ab></ab>		PFI0, PXI_Trig<07>, PXI_Star, PXIe_DStar <ab></ab>	
Polarity Rising or falling edge, software-selectable		Rising or falling edge, software-selectable	

- 6. Valid between PXIe-4480 modules installed in the same chassis. Between PXIe-4480 modules in different chassis, add the potential skew in the PXI_CLK10 clock distribution. Refer to the appropriate chassis documentation for its clock skew specifications.
- 7. Listed accuracy is valid for 30 days following a timebase change. T_{tb} = ambient temperature at which the timebase source was last changed.

Minimum pulse width	100 ns for PXI_Trig<07>, 20 ns for others

Output Timing Signals

Sources	Start Trigger Out, Reference Trigger Out, Sync Pulse Out
Destinations	PFI0, PXI_Trig<07>, PXIe_DStarC
Polarity	Software-selectable except for Sync Pulse Out (always active low)

PFI0 (Front Panel Digital Trigger)

Input	
Logic compatibility	3.3 V or 5 V
Input range	0 V to 5.5 V
VIL	0.95 V maximum
ViH	2.4 V minimum
Input impedance	10 kΩ
Overvoltage protection	±10 V peak
Output	

Output range	0 V to 3.45 V
V _{OL}	0.33 V maximum at 5 mA
V _{OH}	2.8 V minimum at 5 mA
Output impedance	50 Ω
Output current	±5 mA maximum

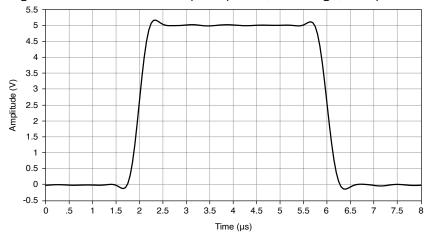
Time Domain Mode

Base sample rate	20 MSample/s	
Sample rate decimation ⁸	Base sample rate divided by integers 1 to 15	
Default FIR filter ⁹		
Туре		Equiripple low pass
Number of taps		35
Passband ripple		±5 mdB (DC to 800 kHz)

- 8. Time domain mode always operates and filters at the base sample rate of 20 MSample/s. Users may request a slower sample rate that the module will create by dropping samples to decimate down to the requested rate.
- 9. Digital filter is user-programmable. Refer to the *PXIe-4480/4481 User Manual* for more details.

Stopband attenuation	≥ 120 dB, f_{in} ≥ 3.9 MHz	
Effective number of bits (ENOB)		
10 V range	13.2	
5 V range	13.5	
1 V range	13.5	
0.5 V range	13.1	

Figure 23. Time Domain Step Response, 5 V Range, Sampled at 20 MSample/s





Note The measured step response is affected by both the fixed anti-aliasing analog filtering and the digital filter used. Signal measured for step response had a rise/fall time of less than 15 ns.

General Specifications

This section lists general specification information for the PXIe-4480.

Bus Interface

Form factor	x4 PXI Express peripheral module, Specification rev. 1.0 compliant
Slot compatibility	PXI Express or PXI Express hybrid slots
DMA channels	3, analog input

Power Requirements

Voltage (V)	Current (A), Maximum (Typical)
+3.3	2.0 (1.5)
+12	3.0 (2.5)

Physical

Clean the hardware with a soft, nonmetallic brush. Make sure that the hardware is completely dry and free from contaminants before returning it to service.

Dimensions (not including connectors)	16 cm x 10 cm (6.3 in. x 3.9 in.) 3U CompactPCI slot
Analog input connector	InfiniBand 12x
Digital trigger connector (PFI0)	SMB male
Front-panel LEDs	2 (Access, Active)

Weight	264 g (9.3 oz)
Measurement Category	1 ¹⁰



Caution Do not connect the product to signals or use for measurements within Measurement Categories II, III, or IV.



Attention Ne pas connecter le produit à des signaux dans les catégories de mesure II, III ou IV et ne pas l'utiliser pour effectuer des mesures dans ces catégories.



Caution Observe all instructions and cautions in the user documentation. Using the product in a manner not specified can damage the product and compromise the built-in safety protection.



Attention Suivez toutes les instructions et respectez toutes les mises en garde de la documentation d'utilisation. L'utilisation du produit de toute autre façon que celle spécifiée risque de l'endommager et de compromettre la protection de sécurité intégrée.

Environmental

Operating Environment

Ambient temperature range	0 °C to 55 °C (Tested in accordance with IEC 60068-2-1 and IEC 60068-2-2.)
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10. Measurement Categories CAT I and CAT O are equivalent. These test and measurement circuits are not intended for direct connections to the MAINS building installations of Measurement Categories CAT II, CAT IV.

Relative humidity range	10% to 90%, noncondensing (Tested in accordance with IEC 60068-2-56.)
Altitude	2,000 m (800 mbar)
Pollution degree	2

Indoor use only.

Storage Environment

Ambient temperature range	-40 °C to 71 °C (Tested in accordance with IEC 60068-2-1 and IEC 60068-2-2.)
Relative humidity range	5% to 95%, noncondensing (Tested in accordance with IEC 60068-2-56.)

Shock and Vibration

Operational shock	30 g peak, half-sine, 11 ms pulse (Tested in accordance with IEC-60068-2-27. Test profile developed in accordance with MIL-PRF-28800F.)	
Random vibration		
Operating	5 Hz to 500 Hz, 0.3 g RMS	
Nonoperating	5 Hz to 500 Hz, 2.4 g RMS (Tested in accordance with IEC-60068-2-64. Nonoperating test profile exceeds the requirements of MIL-PRF-288800F, Class 3.)	

Calibration

External calibration interval	2 years
Warm-up time	15 minutes

Safety Compliance Standards

This product is designed to meet the requirements of the following electrical equipment safety standards for measurement, control, and laboratory use:

- IEC 61010-1, EN 61010-1
- UL 61010-1, CSA C22.2 No. 61010-1



Note For safety certifications, refer to the product label or the <u>Product</u> <u>Certifications and Declarations</u> section.

Electromagnetic Compatibility

This product meets the requirements of the following EMC standards for electrical equipment for measurement, control, and laboratory use:

- EN 61326-1 (IEC 61326-1): Class A emissions; Controlled immunity
- EN 55011 (CISPR 11): Group 1, Class A emissions
- EN 55022 (CISPR 22): Class A emissions
- EN 55024 (CISPR 24): Immunity
- AS/NZS CISPR 11: Group 1, Class A emissions
- AS/NZS CISPR 22: Class A emissions
- FCC 47 CFR Part 15B: Class A emissions
- ICES-001: Class A emissions



Note Group 1 equipment (per CISPR 11) is any industrial, scientific, or medical equipment that does not intentionally generate radio frequency

energy for the treatment of material or inspection/analysis purposes.



Note In the United States (per FCC 47 CFR), Class A equipment is intended for use in commercial, light-industrial, and heavy-industrial locations. In Europe, Canada, Australia and New Zealand (per CISPR 11) Class A equipment is intended for use only in heavy-industrial locations.



Note For EMC declarations and certifications, and additional information, refer to the **Online Product Certification** section.

CE Compliance (¿

This product meets the essential requirements of applicable European Directives, as follows:

- 2014/35/EU; Low-Voltage Directive (safety)
- 2014/30/EU; Electromagnetic Compatibility Directive (EMC)

Product Certifications and Declarations

Refer to the product Declaration of Conformity (DoC) for additional regulatory compliance information. To obtain product certifications and the DoC for NI products, visit <u>ni.com/product-certifications</u>, search by model number, and click the appropriate link.

Environmental Management

NI is committed to designing and manufacturing products in an environmentally responsible manner. NI recognizes that eliminating certain hazardous substances from our products is beneficial to the environment and to NI customers.

For additional environmental information, refer to the *Engineering a Healthy* **Planet** web page at <u>ni.com/environment</u>. This page contains the environmental regulations and directives with which NI complies, as well as other environmental information not included in this document.

EU and UK Customers

• X Waste Electrical and Electronic Equipment (WEEE)—At the end of the product life cycle, all NI products must be disposed of according to local laws and regulations. For more information about how to recycle NI products in your region, visit ni.com/environment/weee.

电子信息产品污染控制管理办法(中国RoHS)

• ●●● 中国RoHS—NI符合中国电子信息产品中限制使用某些有害物质指令 (RoHS)。关于NI中国RoHS合规性信息,请登录 ni.com/environment/rohs_china。(For information about China RoHS compliance, go to ni.com/environment/rohs china.)

NI Services

Visit <u>ni.com/support</u> to find support resources including documentation, downloads, and troubleshooting and application development self-help such as tutorials and examples.

Visit <u>ni.com/services</u> to learn about NI service offerings such as calibration options, repair, and replacement.

Visit <u>ni.com/register</u> to register your NI product. Product registration facilitates technical support and ensures that you receive important information updates from NI.

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